Search Notes					

_	Application No.	Applicant(s)
	10/055,645	TRAVERSAT ET AL.
	Examiner	Art Unit
	Tan Lien	2141

	SEARCHED				
Class	Subclass	Date	Examiner		
709	204	3/17/2005	TL		
709	205	3/17/2005	TL		
709	226	3/17/2005	TL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
···	<u> </u>			

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
Inventor Srch	3/17/2005	TL
Con't Srch	3/17/2005	TL
EAST (US Patent & PGPub, EPO, JPO)	3/17/2005	TL
ACM & IEEE	3/17/2005	TL
Consulted with Paul Kang	3/17/2005	TL